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ustomer Contact:	PCN Manager	•				De	pt:	Quality Service
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Assembly Site			Design				Wafer	Bump Site
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Assembly Materials	-	$\frac{\square}{\square}$		per change		H		Bump Process
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e product datasheet(le following change h					w.			TCA9554
Instruments				SCPS:	233E -	-MAF	RCH 2012-RE	VISED FEBRUARY 2017
Changes from Revision D (A	August 2015) to I	Revi	sion E					Page
Added DW package								1
Added Maximum junction t	temperature to th	e Ab	solute Maximul	m Ratings table				5
Added I _{OL} for different T _i to	the Recommend	ded (Operating Cond	litions table				5
Changed I _{CC} standby into								
Changed Cio, Ci maximum								7
Removed ∆I _{CC} spec from t								
Clarified interrupt reset tim								
Made changes to the Inter								
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Added the Calculating Jun								
Changed recommended supply sequencing values Power on reset requirements relaxed								
TEXAS INSTRUMENTS				SCPS196	F_DE	CEM	BER 2010_R	TCA9554A EVISED FEBRUARY 2017
Changes from Revision D (A	August 2015) to I	Revi	sion E	3073130				Page
Added DW package								1
Added Maximum junction temperature to the <i>Absolute Maximum Ratings</i> ⁽¹⁾ table						5		
Added I _{OL} for different T _j to	the Recommend	ded (Operating Cond	litions table				5
	different input sta	tes,	with increased	maximums				7
Changed I _{CC} standby into			arietice table ar	ded ∆l _{cc} typical ch	aract	eris	tics graph .	7
Changed I _{CC} standby into Removed Δ I _{CC} spec from t	the Electrical Cha	racte	ensulos table, ac					_
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Removed ΔI _{CC} spec from t Changed C _{io} , C _i values	ne (t _{ir}) with respec	t to 1	falling edge of A	ACK related SCL pu	lse.			12
Removed Δl _{CC} spec from t Changed C _{io} , C _i values Clarified interrupt reset tim	ne (t _{ir}) with respec <i>rupt Output (INT</i>)	t to t	falling edge of A	ACK related SCL pu	lse.			12
Removed Δl _{CC} spec from the Changed C _{io} , C _i values Clarified interrupt reset time. Made changes to the <i>Inter</i>	ne (t _{ir}) with respect trupt Output (INT) ds section	t to t	falling edge of A	ACK related SCL pu	lse.			

The datasheet number will be changing.

Device Family	Change From:	Change To:
TCA9554	SCPS233D	SCPS233E
TCA9554A	SCPS196D	SCPS196E

These changes may be reviewed at the datasheet links provided.

http://www.ti.com/product/TCA9554 http://www.ti.com/product/TCA9554A

Reason for Change:

To accurately reflect device characteristics.

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.

Changes to product identification resulting from this PCN:

None.

Product Affected:

TCA9554DBQR	TCA9554DBR	TCA9554DWR	TCA9554DWT
TCA9554PWR	TCA9554ADBQR	TCA9554ADBR	TCA9554ADWR
TCA9554ADWT	TCA9554APWR		

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com